International **IGR** Rectifier **POWER MOSFET SURFACE MOUNT (D3 PAK)**

IRFMJ044 60V, N-CHANNEL HEXFET[®] MOSFET TECHNOLOGY

Product Summary

Part Number	RDS(on)	ID	
IRFMJ044	0.04 Ω	35A*	

HEXFET[®] MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.



Features:

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Dynamic dv/dt Rating
- Light-weight
- Screened to JANTX Level per MIL-PRF-19500

Parameter			Units	
ID @ VGS = 10V, TC = 25°C	Continuous Drain Current	35*		
ID @ VGS = 10V, TC = 100°C Continuous Drain Current		28	A	
IDM	Pulsed Drain Current ①	140	140	
P _D @ T _C = 25°C	Max. Power Dissipation	125	W	
	Linear Derating Factor	1.0	W/°C	
VGS Gate-to-Source Voltage		±20	V	
EAS Single Pulse Avalanche Energy 2		340	mJ	
IAR Avalanche Current ①		35	A	
EAR	Repetitive Avalanche Energy ①	12.5	mJ	
dv/dt Peak Diode Recovery dv/dt 3		4.5	V/ns	
Тј	Operating Junction	-55 to 150		
TSTG	Storage Temperature Range		°C	
	Weight	9.3 (Typical)	g	

Absolute Maximum Ratings

*Current is limited by package For footnotes refer to the last page

International **tor** Rectifier

	Parameter	Min	Тур	Мах	Units	Test Conditions
BVDSS	Drain-to-Source Breakdown Voltage	60	_	_	V	VGS = 0V, ID = 1.0mA
∆BV _{DSS} /∆TJ	Temperature Coefficient of Breakdown Voltage	_	0.68	_	V/°C	Reference to 25°C, $I_D = 1.0$ mA
RDS(on)	Static Drain-to-Source On-State	_	—	0.04	. Ω	VGS = 10V, ID = 28A
. ,	Resistance			0.05	52	VGS = 10V, ID = 35A
VGS(th)	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$
9fs	Forward Transconductance	17	—	—	S (7)	V _{DS} > 15V, I _{DS} = 28A ④
IDSS	Zero Gate Voltage Drain Current	—	—	25	μA	V _{DS} = 48V ,V _{GS} =0V
		—	—	250	μΑ	$V_{DS} = 48V,$
						$V_{GS} = 0V, T_{J} = 125^{\circ}C$
IGSS	Gate-to-Source Leakage Forward	—	—	100	-	VGS = 20V
IGSS	Gate-to-Source Leakage Reverse	—	—	-100	nA	$V_{GS} = -20V$
Qg	Total Gate Charge	—	—	88		VGS =10V, ID = 35A
Q _{gs}	Gate-to-Source Charge			15	nC	$V_{DS} = 30V$
Q _{gd}	Gate-to-Drain ('Miller') Charge	_	—	52		
^t d(on)	Turn-On Delay Time	—	—	23		$V_{DD} = 30V, I_D = 35A,$
tr	Rise Time	—	—	130		VGS =10V, RG = 9.1Ω
^t d(off)	Turn-Off Delay Time	—	—	81	ns	
tf	Fall Time		_	79		
C _{iss}	Input Capacitance	_	2400	—		$V_{GS} = 0V, V_{DS} = 25V$
C _{OSS}	Output Capacitance	—	1100	—	pF	f = 1.0MHz
C _{rss}	Reverse Transfer Capacitance	—	230	—		

Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

Source-Drain Diode Ratings and Characteristics

	Parameter	Min	Тур	Мах	Units	Test Conditions
IS	Continuous Source Current (Body Diode)	_	_	35*	Α	
ISM	Pulse Source Current (Body Diode) ①	—	—	140		
VSD	Diode Forward Voltage			2.5	V	Tj = 25°C, IS = 35A, VGS = 0V ④
t _{rr}	Reverse Recovery Time	-	-	220	ns	$T_j = 25^{\circ}C$, $I_F = 35A$, $di/dt \le 100A/\mu s$
QRR	Reverse Recovery Charge	—	—	1.6	μC	$V_{DD} \le 50V @$
ton	Forward Turn-On Time Intrinsic turn-c	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_{S} + L_{D}$.				

*Current is limited by package

Thermal Resistance

	Parameter	Min	Тур	Max	Units	Test Conditions
RthJC	Junction-to-Case	_	—	1.0		
RthJCS	Case-to-Sink	-	0.21		°C/W	
RthJA	Junction-to-Ambient	—	—	48		Typical socket mount

For footnotes refer to the last page

International

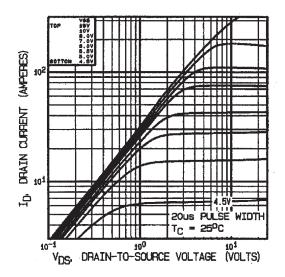


Fig 1. Typical Output Characteristics

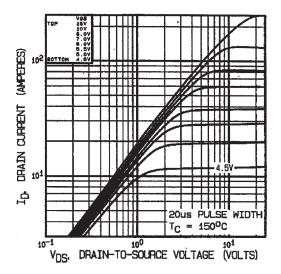


Fig 2. Typical Output Characteristics

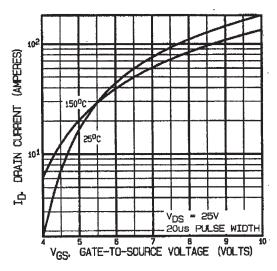
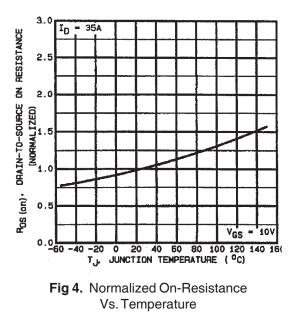


Fig 3. Typical Transfer Characteristics





3

International **TOR** Rectifier

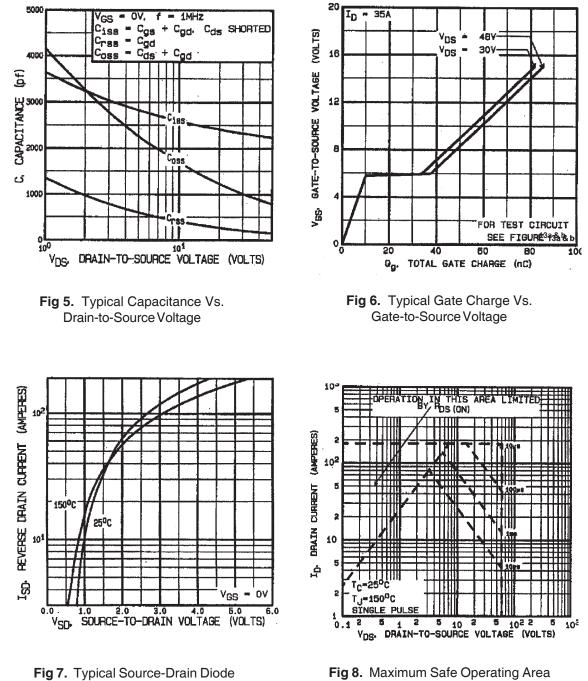


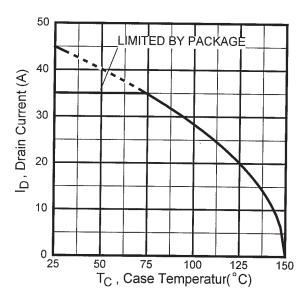
Fig 8. Maximum Safe Operating Area

www.irf.com

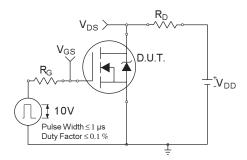
4

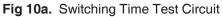
Forward Voltage

International









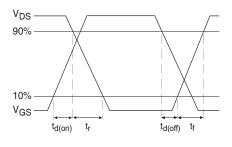


Fig 10b. Switching Time Waveforms

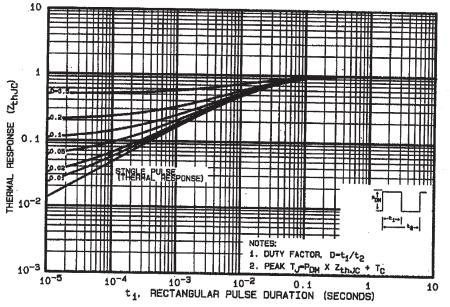


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

International

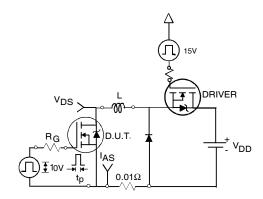


Fig 12a. Unclamped Inductive Test Circuit

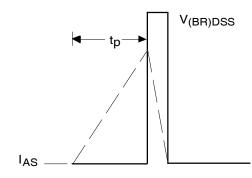


Fig 12b. Unclamped Inductive Waveforms

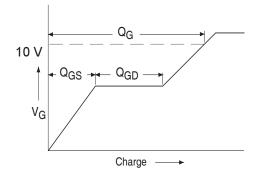


Fig 13a. Basic Gate Charge Waveform

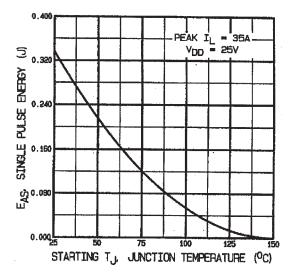


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

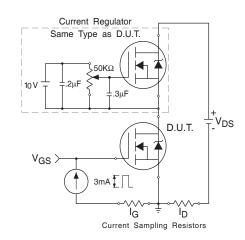


Fig 13b. Gate Charge Test Circuit

www.irf.com

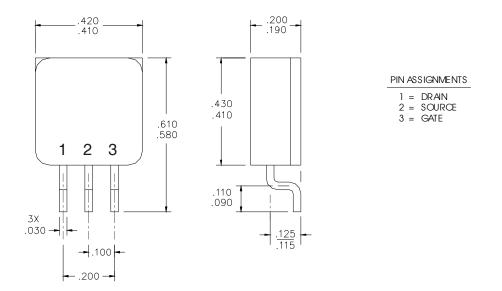
6

International

Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- $@~V_{DD}$ = 25V, starting TJ = 25°C, L= 0.5mH Peak IL = 35A, VGS = 10V
- 3 I_{SD} \leq 35A, di/dt \leq 100A/µs,
- $V_{DD} \le 60V, T_{J} \le 150^{\circ}C$
- 4 Pulse width \leq 300 $\mu s;$ Duty Cycle \leq 2%

Case Outline and Dimensions — D3 PAK



International

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105 IR LEOMINSTER : 205 Crawford St., Leominster, Massachusetts 01453, USA Tel: (978) 534-5776 TAC Fax: (310) 252-7903 Visit us at www.irf.com for sales contact information.

Data and specifications subject to change without notice. 09/2006